Time Stamping CDC/TPC Comparison Studies Keisuke Fujii, KEK

Why Time Stamping?







2-Photon Mini-Jet Production $\langle E \rangle \simeq 2.5~{
m GeV}$ $\langle n_{
m ch} \rangle \simeq 5$ in chamber acceptance



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How to Time-Stamp a Track?

Signature State Stat

Staggered Cells

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Staggered Cells



Staggered Cells



Staggered Cells



Staggered Cells

Sin the Case of JLC-CDC



Staggered Cells



Staggered Cells

Sin the Case of JLC-CDC



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Sin the Case of JLC-CDC



Staggered Cells

$$\Delta \mathbf{x} = 2 \ v_{\rm drift} \times \Delta T_0$$

In the Case of JLC-CDC



Staggered Cells

Wrong TO breaks a track!

$$\Delta \mathbf{x} = 2 v_{\text{drift}} \times \Delta T_0$$

Naively we expect

In the Case of JLC-CDC



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In the Case of TPC

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External Z Detector (TO Device)

In the Case of TPC



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$$\Delta \mathbf{z} = v_{\rm drift} \times \Delta T_0$$
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Naively we expect $\sigma_{\Delta T_0} \simeq \frac{2\sigma_z}{v_{\text{drift}}\sqrt{n}} \left[1 + 3\left(\frac{d}{L}\right) + 3\left(\frac{d}{L}\right)^2 \right]^{-\frac{1}{2}}$

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m if} \quad \left(rac{d}{L}
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In the Case of TPC



Assuming that Z resolution of the external detector is negligible

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$$\simeq \frac{2\sigma_z}{v_{\text{drift}}\sqrt{n}} \quad \text{if} \quad \left(\frac{d}{L}\right) \ll 1$$

In the Case of TPC



Assuming that Z resolution of the external detector is negligible $\sigma_z = 500 \ \mu m$ $v_{\rm drift} = 5 \ {\rm cm}/\mu {\rm s}$ n = 120

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Wrong TO makes a Z-shift!

$$\Delta \mathbf{z} = v_{\rm drift} \times \Delta T_0$$

Naively we expect $\sigma_{\Delta T_0} \simeq \frac{2\sigma_z}{1 + 3\left(\frac{d}{\tau}\right) + 3\left(\frac{d}{\tau}\right)^2}$

$$\simeq \frac{1}{v_{\text{drift}}\sqrt{n}} \begin{bmatrix} 1+3\left(\overline{L}\right)+3\left(\overline{L}\right) \end{bmatrix}$$

$$\simeq \frac{2\sigma_z}{v_{\text{drift}}\sqrt{n}} \quad \text{if} \quad \left(\frac{d}{L}\right) \ll 1$$



More Realistic Estimation

Helix Fit CDC Hits with TO as an Additional Fit Parameter

CDC Case

CDC Case

Chi2 Distribution (axial only)

CDC Case

Chi2 Distribution (axial only)



CDC Case

Chi2 Distribution (axial only)



-----> Fit seems OK!

TO from Helix Fit (axial only, 100GeV)

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TO from Helix Fit (axial only, 100GeV)



We can determine TO with ~1.8ns accuracy as expected!

What happens if we add stereo layers?

At certain Z positions, we lose L/R staggering of the neighboring layers!

Stereo layers allow additional freedom to eliminate track discontinuity by adjusting dip angle!

----> Degradation of time stamping capability?

Chi2 Distribution (axial+stereo, 100GeV)

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Chi2 Distribution (axial+stereo, 100GeV)



→ Fit seems OK!

© TO from Helix Fit (axial+stereo, 100GeV)

TO from Helix Fit (axial+stereo, 100GeV)



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TO from Helix Fit (axial+stereo, 100GeV)



We can still determine TO with ~2.2ns accuracy!

What about Low Pt Tracks?

K.Fujii @ LC-TPC TPC R&D Meeting Multiple Scattering Effects (axial+stereo, 1GeV)

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In the Case of TPC

Assuming a generic TPC with

and a T(

$$R_{out}-R_{in}=120~{
m cm}$$

 $\sigma_{
m xy}=150~\mu{
m m}$
 $\sigma_{
m z}=500~\mu{
m m}$
 $B=4{
m T}$
 $n=120$
 $v_{
m drift}=5~{
m cm}/\mu{
m s}$
O device with
 $\sigma_{
m z}^{T_0}=10~\mu{
m m}$

Helix Fit TPC hits Including the External Z Hit with TO as an Additional Fit Parameter

• TO from Helix Fit (d=5cm, 100GeV)

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TO from Helix Fit (d=5cm, 100GeV)



We can determine TO with ~2.0ns accuracy as expected!

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0.6%X0 to 3.0%X0 --> 2% shift in TO resolution

Summary & Conclusions

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Multiple scattering effect is, however, more significant.

Refinement of the mini-Jet BG estimate.

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Effect of curling up tracks.

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Further Studies Refinement of the mini-Jet BG estimate. Effect of curling up tracks. Effect is probably more serious for TPC than for CDC. Linking to VTXD to eliminate primary tracks

originating from a displaced vertex in Z.

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- Effect of curling up tracks.
 - Effect is probably more serious for TPC than for CDC.
- Linking to VTXD to eliminate primary tracks originating from a displaced vertex in Z.
- Repeat everything for multi-jet events.